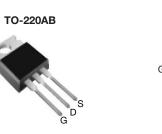
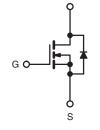


**Vishay Siliconix** 

#### Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	250				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 2.0				
Q <sub>g</sub> (Max.) (nC)	8.2				
Q <sub>gs</sub> (nC)	1.8				
Q <sub>gd</sub> (nC)	4.5				
Configuration	Single				





N-Channel MOSFET

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF614PbF
Lead (Fb)-liee	SiHF614-E3
SnPb	IRF614
	SiHF614

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	250	v	
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C		2.7		
	VGS at 10 V	T <sub>C</sub> = 100 °C	Ι <sub>D</sub>	1.7	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	8.0		
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	61	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	2.7	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	3.6	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		PD	36	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>		
Mounting Toyous	6-32 or M3 screw			10	lbf ∙ in	
Mounting Torque				1.1	N·m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 13 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 2.7$  A (see fig. 12).

c.  $I_{SD} \le 2.7$  A, dl/dt  $\le 65$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

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### Vishay Siliconix



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP.		MAX.	MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62 - 3.5					
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50				°C/W			
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-							
EDECIEICATIONS /T - 25 °C	place otherw	ico potod)							
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, u PARAMETER	SYMBOL				MINI	TYP		LINUT	
Static	STMBOL	TEST	CONDITIC	JNS	MIN.	TYP.	MAX.	UNIT	
Drain-Source Breakdown Voltage	N/	<u> </u>	$\gamma \gamma = 2$	50 ···A	250	[	[	. v	
ů	$V_{DS}$ $\Delta V_{DS}/T_{J}$	Reference	$V, I_D = 2$		250	0.39	-	V	
V <sub>DS</sub> Temperature Coefficient						0.39		V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>		$I_{\rm GS}, I_{\rm D} = 2$	-	2.0	-	4.0	V	
Gate-Source Leakage	I <sub>GSS</sub>		$s = \pm 20$		-	-	± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	-	50 V, V <sub>GS</sub>		-	-	25	μA	
		$V_{DS} = 200 V, V_{DS}$			-	-	250		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$ $I_D = 1.6 A^b$		-	-	2.0	Ω		
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 50 \text{ V}, I_D = 1.6 \text{ A}^{b}$			0.90	-	-	S	
Dynamic		i .				r	r	i	
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V,$			-	140	-	pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 25 V,			-	42	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	9.6	-			
Total Gate Charge	Qg			A \/ 000.\/	-	-	8.2		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	10 V $I_D = 2.7 \text{ A}, V_{DS} = 200 \text{ V}$ see fig. 6 and 13 <sup>b</sup>		-	-	1.8	nC	
Gate-Drain Charge	Q <sub>gd</sub>				-	-	4.5		
Turn-On Delay Time	t <sub>d(on)</sub>				-	7.0	-		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 125 V, I <sub>D</sub> = 2.7 A , R <sub>q</sub> = 24 Ω, R <sub>D</sub> = 45 Ω, see fig. 10 <sup>b</sup>		-	7.6	-	ns		
Turn-Off Delay Time	t <sub>d(off)</sub>			-	16	-			
Fall Time	t <sub>f</sub>		D = 40 32,	see lig. To	-	7.0	-	1	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	L <sub>S</sub>			-	7.5	-			
Drain-Source Body Diode Characteristic	s							•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.7			
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	8.0	А		
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 2.7 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	2.0	v		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_{J} = 25 \text{ °C}, I_{F} = 2.7 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}^{\text{b}}$ Intrinsic turn-on time is negligible (turn			-	190	390	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.64	1.3	μC		
Forward Turn-On Time	t <sub>on</sub>			an ia dau	minatad h	ul and			

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.

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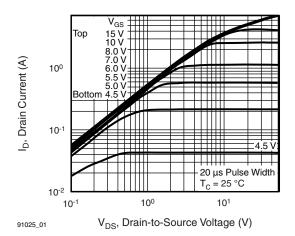


Fig. 1 - Typical Output Characteristics,  $T_C = 25 \ ^{\circ}C$ 

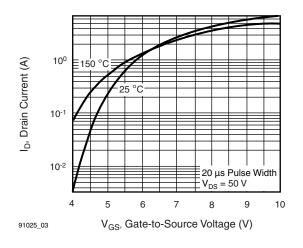


Fig. 3 - Typical Transfer Characteristics

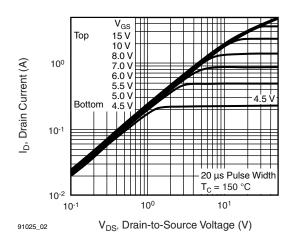


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

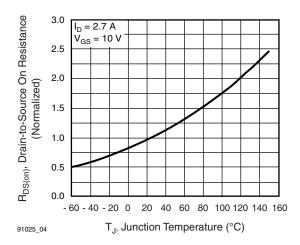


Fig. 4 - Normalized On-Resistance vs. Temperature

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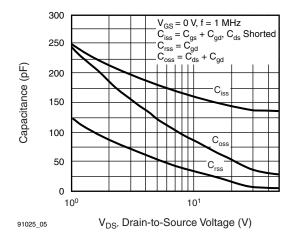


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

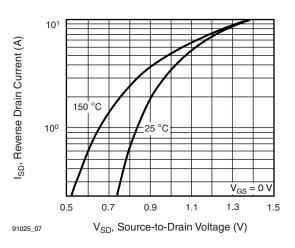


Fig. 7 - Typical Source-Drain Diode Forward Voltage

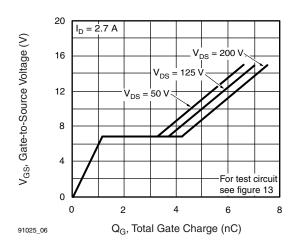


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

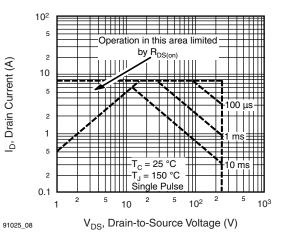


Fig. 8 - Maximum Safe Operating Area

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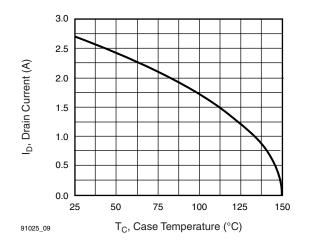


Fig. 9 - Maximum Drain Current vs. Case Temperature

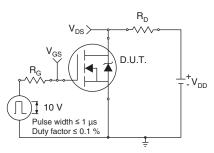


Fig. 10a - Switching Time Test Circuit

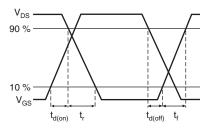


Fig. 10b - Switching Time Waveforms

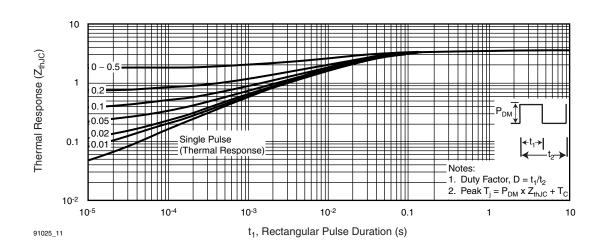


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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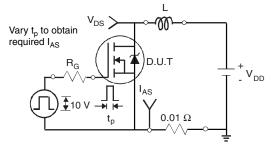


Fig. 12a - Unclamped Inductive Test Circuit

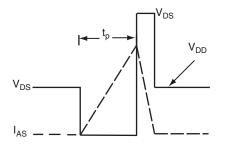
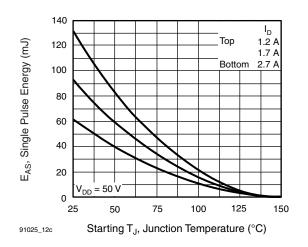


Fig. 12b - Unclamped Inductive Waveforms





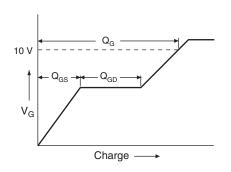
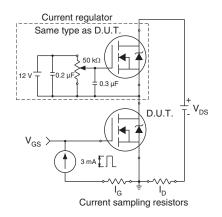


Fig. 13a - Basic Gate Charge Waveform



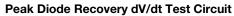


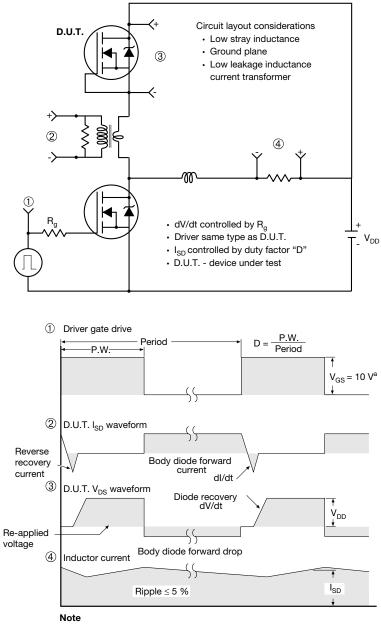
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a.  $V_{GS} = 5 V$  for logic level devices

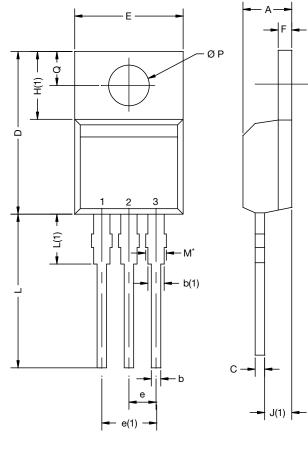
Fig.14 - For N-Channel

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TO-220-1



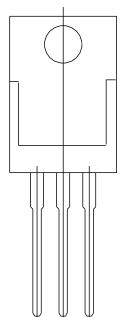
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DIM	MILLIM	IETERS	INCHES		
DIM.	MIN. M		MIN.	MAX.	
А	4.14	4.70	0.163	0.185	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.32	15.86	0.564	0.624	
E	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	0.51	1.40	0.020	0.055	
H(1)	6.10	6.70	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.05	0.131	0.159	
ØΡ	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15-0 DWG: 6031	0339-Rev. B,	02-Nov-15			

Note

-  $M^{\star}$  = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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